

Automated Micro and Nanoscale Assembly using Optical Tweezers

Arvind Balijepalli, Ashis Gopal Banerjee, Tom LeBrun, Tao Peng, and S.K. Gupta Sponsors: NSF, NIST, and Center for Nano Manufacturing and Metrology



Motivation

- · Automated 3D assembly of micro and nanoscale components is challenging
- · Optical tweezers can be used to trap and move micro and nanoscale components
- · Examples of devices that can be assembled using optical tweezers include wave guides, diodes, transistors etc.
- Optical tweezers are useful for studying characteristics of biological cells
- · Currently assemblies are performed manually using optical tweezers
- · Automation is essential for industrial viability



Examples of optical tweezers based assembly

Assembly Cell

Re

structed 3D model

mode

Software

Goals

- · Develop automated assembly cell based on optical tweezers
- 3D imaging system for tracking locations of components in real-time - Physically accurate framework for simulating assembly operations
- Automated path planning algorithms for transporting components to goal locations by avoiding collisions



Optical Trapping



glass sphere moves towards foca point C

The optical tweezers instrument is built around a conventional optical microscope for convenience

Automated Path Planning

· Develop algorithms to automatically trap and transport particles

Challenges

- Dynamic environment involving random Brownian motion of particles - Presence of uncertainties due to Brownian motion and sensor noise
- Real-time computation within few milliseconds

Approach

- Develop simplified trapping probability model by using Gaussian Radial Basis Functions
- Develop single particle path planning algorithm using stochastic dynamic programming (Partially Observable Markov Decision Process)
- Integrate dynamic programming algorithm in a decoupled and prioritized framework for multi-particle transport



3D Imaging Using Optical Section Microscopy

- Use images provided by optical section microscopy to estimate sizes and locations of components in workspace Controller Challenges Noisv images D Workspa Construction
- Images include optical effects in translucent materials
- High degree of uncertainty in reconstructed shapes - scenes need to be updated at high rates
- Approach
- Retrieve geometric information of components from individual images
- Combine information from adjacent focal plane images







Estimating the lengths. center positions, inplane orientation angles and tilt angles of

nanowires





- · Develop a simulation framework to test control algorithms, estimate physical parameters, and perform statistical validation of assembly with optical tweezers
- Challenges
- Physically accurate simulations
- Experimental validation to improve confidence in simulation results
- Approach
- Particle diffusion modeling using Brownian Dynamics on graphics hardware for significant speedup without compromising accuracy
- Experimental optical force measurement techniques to measure trapping
- potential (such as step response below) - Optical trapping force calculation from first principles using Mie theory



Clockwise from the top left; i) the trajectory of a particle as it moves towards the center of the optical trap in the xy-plane, ii) the optical trapping force and trapping potential sampled at different angles in the xy-plan (inset shows a 3D-representation) and iii) an isosurface of the optical trapping potential model in 3D.